

NTE5442 thru NTE5448 Silicon Controlled Rectifier (SCR) 8 Amp

Description:

The NTE5442 thru NTE5448 are silicon controlled rectifiers (SCR's) in a TO127 type package designed for high-volume consumer phase-control applications such as motor speed, temperature, and light controls, and for fast switching applications in ignition and starting systems, voltage regulators, vending machines, and lamp drivers.

Features:

- Small, Rugged Construction
- Practical Level Triggering and Holding Characteristics @ +25°C:

 $I_{GT} = 7mA Typ$ $I_{Hold} = 6mA Typ$

- Low "ON" Voltage: V_{TM} = 1V Typ @ 5A @ +25°C
- High Surge Current Rating: I_{TSM} = 80A

<u>Absolute Maximum Ratings:</u> (Note 1, $T_J = +100^{\circ}$ C unless otherwise specified)	
Peak Repetitive Forward and Reverse Blocking Voltage (Note 2), V _{DRM} or V _{RRM}	
NTE5442	
NTE5444	200V
NTE5446	400V
NTE5448	600V
Non-Repetitive Peak Reverse Blocking Voltage (t = 5ms (max) duration), V _{RSM}	
NTE5442	75V
NTE5444	300V
NTE5446	500V
NTE5448	700V
RMS On-State Current (All Conduction Angles), I _{T(RMS)}	8A
Average On-State Current ($T_C = +73^{\circ}C$), $I_{T(AV)}$	5.1A
Peak Non-Repetitive Surge Current, I _{TSM}	
(1/2 cycle, 60Hz preceded and followed by rated current and voltage)	80A
Circuit Fusing ($T_J = -40^\circ$ to $+100^\circ$ C, t = 1ms to 8.3ms), l ² t	25A ² sec
Peak Gate Power, P _{GM}	
Average Gate Power, P _{G(AV)}	۰۰۰۰۰ کا ۱۰۰۰۰ کا ۱۰۰۰ کا ۱۰۰ کا ۱۰ کا ۱۰۰ کا ۱۰
Peak Forward Gate Current, I _{GM}	
Peak Reverse Gate Voltage, V _{RGM}	
Operating Junction Temperature Range, T _J	
Storage Temperature Range, T _{stq}	
Maximum Thermal Resistance, Junction-to-Case, R _{thJC}	2.5°C/W
Typical Thermal Resistance, Junction-to-Ambient, RthJA	
Note 1 NTEF446 is a disceptioned device and is replaced by NTEF449	

- Note 1. NTE5446 is a discontinued device and is replaced by NTE5448.
- Note 2. Ratings apply for zero or negative gate voltage but positive gate voltage shall not be applied concurrently with a negative potential on the anode. When checking forward or reverse blocking capability, thyristor devices should not be tested with a constant current source in a manner that the voltage applied exceeds the rated blocking voltage.

Electrical Characteristics: $(T_C = +25^{\circ}C \text{ unless otherwise specified})$

Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
Peak Forward or Reverse Blocking Current	I _{DRM} , I _{RRM}	Rated V _{DRM} or V _{RRM} , Gate Open	$T_J = +25^{\circ}C$	-	-	10	μΑ
			T _J = +100°C	-	-	2	mA
Gate Trigger Current (Continuous DC)	I _{GT}	$V_D = 7V, R_L = 100\Omega$	$T_{C} = +25^{\circ}C$	-	7	30	mA
			$T_C = -40^{\circ}C$	-	-	60	mA
Gate Trigger Voltage (Continuous DC)	V _{GT}	$V_D = 7V$, $R_L = 100\Omega$	$T_C = +25^{\circ}C$	-	0.75	1.5	V
			$T_C = -40^{\circ}C$	-	-	2.5	V
		V_D = Rated V_{DRM} , R_L = 100 Ω , T_J = +100 $^{\circ}$ C		0.2	-	-	V
Peak On-State Voltage	V _{TM}	V _{TM} Pulse Width = 1ms to 2 ms, Duty Cycle ≤ 2%	$I_{TM} = 5A_{peak}$	1	1.0	1.5	V
			$I_{TM} = 15.7A_{peak}$	1	-	2.0	V
Holding Current	I _{Hold}	old V _D = 7V, Gate Open	$T_C = +25^{\circ}C$	1	6	40	mA
			$T_C = -40^{\circ}C$	1	-	70	mA
Gate Controlled Turn-On Time	t _{gt}	$I_{TM} = 5A$, $I_{GT} = 20mA$, $V_D = Rated V_{DRM}$		1	1	1	μs
Circuit Commutated Turn-Off Time	t _q	t_q $I_{TM} = 5A$, $I_R = 5A$		1	15	1	μs
			T _J = +100°C	-	20	-	μs
Critical Rate-of-Rise of Off-State Voltage	dv/dt	V_D = Rated V_{DRM} , Exponential Waveform, T_J = +100°C, Gate Open			50	-	V/μs

